

<b>Notice of References Cited</b>	Application/Control No. 10/530,124		Applicant(s)/Patent Under Reexamination SAITO ET AL.	
	Examiner Eric S. McCall		Art Unit 2855	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0064977	03-2006	Ohlig et al.	060/534
*	B	US-2005/0269871	12-2005	Saito, Kiyoshi	303/020
*	C	US-6,871,916	03-2005	Stephane et al.	303/113.4
*	D	US-6,668,659	12-2003	Morikawa et al.	73/729.1
*	E	US-6,595,045	07-2003	Fuglewicz et al.	73/129
*	F	US-6,446,500	09-2002	Marquardt et al.	73/132
*	G	US-6,031,448	02-2000	Starkweather et al.	338/106
*	H	US-5,563,355	10-1996	Pluta et al.	73/862.625
*	I	US-5,217,280	06-1993	Nykerk et al.	303/3
*	J	US-5,115,186	05-1992	Reinartz et al.	324/207.22
*	K	US-4,206,636	06-1980	Hendrix, Tony D.	73/132
*	L	US-3,788,131	01-1974	Markey, Francis J.	73/132
*	M	US-3,602,043	08-1971	Markey, Francis J.	73/132

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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